Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/938,174	LEUNG ET AL.	
Examiner	Art Unit	_
Haresh Patel	2154	

	SEARCHED				
Class	Subclass	Date	Examiner		
709	230-238 200-203 217-229	118/05	H.P.		
370	329,252	1			
370	328,331-334				
340	341,431,				
455	423-425,				
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714	791-795	11/8/05	H.P.		
375	262,261, 265,325,34	11/8/05	H.P.		
375	130,144,	11/8/05	H.P.		
455	226·1+b 226·3	11/8/05	H.P.		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST, US-PAT, US-PUB, EPO, 9PO, Derwert, 1BM-TDB, JEEE Xplose, ACM Digtal library, 400ge	11/8/05	H.P.